

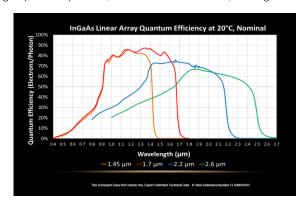
1024-LDM Linescan Camera

Compact InGaAs Linescan Camera for Machine Vision

The model 1024-LDM-G camera is a high-speed 1024-pixel linescan InGaAs camera with GigE-vision compatibility for use in high-resolution imaging through silicon wafers, blocks or ingots. It finds problems such as misalignment, occlusions, inclusions or cracks; before the expense of further processing of ICs or solar cells. It is also valuable for high-speed imaging of free-falling molten glass gobs, or for inspection of agricultural raw materials, or pharmaceutical mixes. The camera offers flexible line rates of up to 45,956 lps (when using high performance Ethernet drivers) in the PC. Only 3.75 inches in depth, the mechanical design gives system integrators the flexibility to fit the camera inside their inspection machines. The LDM-G provides 14-bit digital capture with dynamic ranges up to 4500:1. A photoetch mask sharply defines the array's 25-µm aperture, ensuring high time and spatial resolution.

APPLICATIONS

- Inspection through polished silicon wafers or blocks
- Machine vision for ultra-high speed inspection, materials classification, sorting
- and/or monitoring of continuous processes, for example for food or agricultural product sorting
- Fast absorption or emission spectroscopy for combustion research, moisture, lipids, proteins or other molecular vibration bands in the 0.8 µm-1.7 µm range



FEATURES

- High quantum efficiency and dynamic range
- Integrate-while-read snapshot acquisition
- Predefined line rates from 80 to 45,956 lps user programmable
- Wavelength response over 0.8 µm to 1.7 µm
- 1024 x 25-µm pixel pitch with the aperture heights of 25 or 500 µm
- 14-bit base Camera Link® compatible
- Operating temperature range of -10 to +50°C
- Light-tight mount for spectrometers
- Mounts easily to optics benches or MV systems with tripod, front or side fastener hole patterns
- Optional adapters for F-mount or C-mount, lenses (C-mount lenses may not fully illuminate the full width of the 25.6 mm wide arrays)



MECHANICAL					
Length x Width x Height:	6.1 cm x 7.37 cm x 7.62 cm 2.4 in x 2.9 in x 3.00 in Length excludes I/O connectors, and lens adapter				
Weight:	< 450 g or 1 lbs (no lens or adapter)				
Threaded Lens Mount and optional lens mount adapters	M42x1-6H with 5.7 mm to image plane, fixed distance C-Mount adapter or adjustable distance F-Mount adapter (see ordering info)				
Spectrometer mount	4 tapped 8-32 holes in 2 inch square pattern 4 tapped M4x0.7-6H holes spaced 5 cm x 4 cm (h x w) O-Ring light seal, 1.9 inch diameter, 1/16th thickness				
Camera Tripod mount	2 tapped ¼-20 holes alternating on ¾" (19 .05 mm) spacing with 2 tapped M6-6H holes				
Side wall mounts	4 tapped M4x0.7-6H holes, $5 \times 4.5 \text{ cm}$ spacing (h x d)				

INTERFACES						
Control:	SDR 26-pin connector (Base Camera Link®)					
Image Data:	SDR 26-pin connector (Base Camera Link®)					
Power:	Hirose HR10-7R-6PA receptacle Mates with HR10-7P-6S or SN4-8-6(P)					
Sync Output:	SMA: 5 V, 50 W series terminated, active high: integration active					
Trigger Input:	SMA, Low < 0.5, 3 V > high < 5 V					
Status LED:	Green: TEC locked at setpoint Red: TEC unlocked Blinking: Timing or triggering error					
ENVIRONMENTAL AND POWER						
Operating tempera	ature: -10°C to +50°C case temperature					
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	REGULATORY COMPLIANCE
CE:	Meets class A level for emission, immunity and ESD standards
FCC:	Meets requirements for Part 15, Subpart B, Class A, 2006
	-1-0-00 00-10

REGULATORY COMPLIANCE		Storage temperature:	-20°C to 70°C			
		Humidity:	Non-condensing			
CE:	CE: Meets class A level for emission, immunity and ESD standards		Power requirements:	100 040 \/\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\		
FCC:	Meets requirements for Pa	art 15, Subpart B, Class A, 2006	AC adapter supplied DC (voltage/power) In-rush current	100-240 VAC, 47-63 Hz, < 1.0 A 7-16 V, < 6 W at 25°C, < 9 W at 50°C < 1.5 A peak		
ELECTRO-OPTICAL PERFORMANCE						
Sensor format ¹ 1024 pixels on 25 µm pitch with 8 readout A			ADCs			
Optical aperture (pixel height) 1 25 μm square pixel sharply defined by mask on the detector surface or 500 μm photodiode						
Peak qua	ntum efficiency 1	> 70%				

reak quantum emolency	> 1076							
	0.1pF		1.0pF		10.0pf			
Gain capacitor setting	Typical	Specification	Typical	Specification	Typical	Specification		
Net full well capacity (Me-) ²	acity (Me-) ² 1.6 >1.1 15.9 >9.2		>9.2	150 >110				
Gain (e-/cnt) 13	107		1000		9600			
Temporal noise (rms counts) 12	8	< 10	3.5 <4.5		2.5	<3.5		
Dynamic range 124	1900:1	> 1350:1	2600:1	2600:1 > 2100:1		> 2600:1		
Differential non-linearity 12	+/- 0.8%	< +/- 1.2%		< +/- 1.2%	+/- 0.8%	< +/- 1.5%		
Bad pixel specification	White, dark, noisy or pixels exceeding +/- 10% of the mean value when illuminated at 50% of full well							
Zau piner opcomeanon	Number of bad pixels limited to a maximum of 1% of array total; no bad neighbors within 5 pixels							
Exposure time 13	0.018 ms to 12.8 ms in 20 preset steps or to > 1 s with user programmed or via the width of the ext. trigger							
Trigger modes ³	Free run, single line per trigger, external variable exposure, or gated burst							
Sync output	SMA coaxial connector: digital output signal, high during integration							
External trigger input ³	Via frame grabber CC1 signal or SMA coaxial connector on rear panel with selectable polarity							
External variable ET	User set by the duration of trigger input signal (minimum ET pulse: 10 µs)							
External trigger jitter	+/-1 clock cycle: nominally 80 ns with internal ET							
Pixel rate	50 Mpix/s max with 14-bit words transferred on each Camera Link strobe clock cycle							
Digital output format	14-bit base Camera Link®; recommend NI PCIe-1427 or equivalent frame grabber							
Readout mode	Integrate-while-read, correlated differential double sampling							
Corrections (58 preset OPRs)	Factory calibrated gain, offset, and bad pixel replace, applicable to the center 90% of the array							

- ¹ Actual formats and performance governed by user-selected SUI linear array purchased with camera (dark current may limit longest usable ET)
- ²Camera readout noise limited for low & medium gain settings; dark shot noise limited for high gain settings

³ User selectable by command over Camera Link® serial lines

⁴ Dynamic range limited to lowest values listed when camera operated at exposure times shorter than 28 µs due to reduced full well capacity

ORDERING INFORMATION							
Camera Model ¹	Part number	Max. Line rate ¹	Pitch	Pixels	FPA length	Aperture (height)	Classification
SU1024-LDM-1.7RT-0025/LC	8000-0555	45,956 lps	25 µm	1024	25.6 mm	25 µm	6A003.b.4.a
SU1024-LDM-1.7RT-0500/LC	8000-0661	45,956 lps	25 µm	1024	25.6 mm	500 μm	EAR99

¹ Cameras include the photodiode array, whose characteristics dominate camera performance; see the array datasheet for more information

Accessory Kits: Include power supply, carrying case, SMA-BNC trigger in and sync out cables, o-ring, carrying case, mini-CD with manual and free SUI Image. Analysis software for National Instruments Camera Link frame grabbers.

Part Numbers: Kit with F-mount adapter: 8000-0528. Kit with C-mount: 8000-0530. Kit without lens adapter: 8000-0529



For additional information:

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